

### **IR3707-VB** Datasheet N-Channel 30-V (D-S) MOSFET

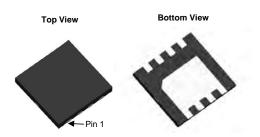
| V <sub>DS</sub>         | 30                   | V  |    |
|-------------------------|----------------------|----|----|
| R <sub>DS(on),typ</sub> | V <sub>GS</sub> =10V | 13 | mΩ |
| RDS(on),typ             | VGS=4.5V             | 19 | mΩ |
| IC                      | 30                   | А  |    |

#### **FEATURES**

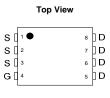
- Halogen-free
- Trench Power MOSFET
- 100 % Rg and UIS Tested

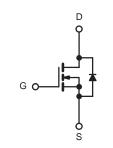
#### **APPLICATIONS**

- DC/DC Conversion - Low-Side Switch
- Notebook PC
- Gaming ٠



DFN 3x3 EP





N-Channel MOSFET

| <b>ABSOLUTE MAXIMUM RATINGS</b> $T_A = 25 \text{ °C}$ , unless otherwise noted |                        |                                   |                      |      |  |
|--|------------------------|-----------------------------------|----------------------|------|--|
| Parameter  |                        | Symbol                            | Limit                | Unit |  |
| Drain-Source Voltage   |                        | V <sub>DS</sub>                   | 30                   | V    |  |
| Gate-Source Voltage  |                        | V <sub>GS</sub>                   | ± 20                 | V    |  |
|  | T <sub>C</sub> = 25 °C |                                   | 30                   |      |  |
| Continuous Drain Current (T <sub>1</sub> = 150 °C)                             | T <sub>C</sub> = 70 °C |                                   | 20                   |      |  |
| Commute Brain Current $(T_j = 150^{\circ} C)$                                  | T <sub>A</sub> = 25 °C | I <sub>D</sub>                    | 21.5 <sup>b, c</sup> |      |  |
|  | T <sub>A</sub> = 70 °C |                                   | 17.1 <sup>b, c</sup> | Α    |  |
| Pulsed Drain Current   |                        | I <sub>DM</sub>                   | 100                  | A    |  |
| Continuous Source-Drain Diode Current  | T <sub>C</sub> = 25 °C | l.                                | 13                   |      |  |
| Continuous Source-Drain Diode Current  | T <sub>A</sub> = 25 °C | I <sub>S</sub>                    | 3.1 <sup>b, c</sup>  |      |  |
| Single Pulse Avalanche Current L = 0.1 mH                                      |                        | I <sub>AS</sub>                   | 10                   |      |  |
| Avalanche Energy   |                        | E <sub>AS</sub>                   | 5                    | mJ   |  |
| Maximum Power Dissipation  | T <sub>C</sub> = 25 °C |                                   | 60                   |      |  |
|  | T <sub>C</sub> = 70 °C | P <sub>D</sub>                    | 30                   | W    |  |
|  | T <sub>A</sub> = 25 °C | 'D                                | 3.7 <sup>b, c</sup>  | VV   |  |
|  | T <sub>A</sub> = 70 °C | 1                                 | 2.4 <sup>b, c</sup>  |      |  |
| Operating Junction and Storage Temperature Range                               |                        | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150          | °C   |  |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |      |  |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit |  |
| Maximum Junction-to-Ambient <sup>b, d</sup> | t ≤ 10 s     | R <sub>thJA</sub> | 27      | 34      | °C/W |  |
| Maximum Junction-to-Foot (Drain)            | Steady State | R <sub>thJF</sub> | 6       | 7.5     | 0/10 |  |

Notes:

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.



| Parameter                                     | Symbol                  | Test Conditions   | Min. | Тур.  | Max.  | Unit       |  |
|---|-------------------------|---|------|-------|-------|------------|--|
| Static  | •                       | ·   | •    |       |       |            |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>         | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA  | 30   |       |       | V          |  |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$   | L 050   |      | 27    |       | mV/°C      |  |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$ | - Ι <sub>D</sub> = 250 μΑ   |      | - 5.6 |       |            |  |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$   | 1.0  |       | 3.0   | V          |  |
| Gate-Source Leakage                           | I <sub>GSS</sub>        | $V_{DS} = 0 V, V_{GS} = \pm 20 V$   |      |       | ± 100 | nA         |  |
|   |                         | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V   |      |       | 1     |            |  |
| Zero Gate Voltage Drain Current               | IDSS                    | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C                             |      |       | 10    | μA         |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>      | $V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$   | 30   |       |       | А          |  |
|   |                         | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A   |      | 13    |       | <b>m</b> 0 |  |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>     | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A  |      | 19    |       | mΩ         |  |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>         | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A   |      | 75    |       | S          |  |
| Dynamic <sup>b</sup>                          | 1                       | 1   |      |       |       | I          |  |
| Input Capacitance                             | C <sub>iss</sub>        |   |      |       | 900   |            |  |
| Output Capacitance                            | C <sub>oss</sub>        | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz  |      |       | 236   | pF         |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>        | 1   |      |       | 20    |            |  |
|   |                         | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A                             |      |       | 20    |            |  |
| Total Gate Charge                             | Qg                      |   |      |       | 9     | nC         |  |
| Gate-Source Charge                            | Q <sub>gs</sub>         | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$                             |      |       | 2.1   |            |  |
| Gate-Drain Charge                             | Q <sub>gd</sub>         | 1   |      |       | 0.7   |            |  |
| Gate Resistance                               | Rg                      | f = 1 MHz   | 0.2  | 1.1   | 2.2   | Ω          |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |      | 8     | 16    | ns         |  |
| Rise Time                                     | t <sub>r</sub>          | V <sub>DD</sub> = 15 V, R <sub>L</sub> = 1.5 Ω  |      | 16    | 30    |            |  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$ |      | 17    | 35    |            |  |
| Fall Time                                     | t <sub>f</sub>          | 1   |      | 7     | 15    |            |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |      | 14    | 30    |            |  |
| Rise Time                                     | t <sub>r</sub>          | V <sub>DD</sub> = 15 V, R <sub>L</sub> = 1.5 Ω  |      | 50    | 100   |            |  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_g = 1 \Omega$           |      | 16    | 30    |            |  |
| Fall Time                                     | t <sub>f</sub>          | 1   |      | 8     | 18    |            |  |
| Drain-Source Body Diode Characterist          | ics                     | •   |      |       |       |            |  |
| Continuous Source-Drain Diode Current         | ۱ <sub>S</sub>          | T <sub>C</sub> = 25 °C  |      |       | 13    |            |  |
| Pulse Diode Forward Current <sup>a</sup>      | I <sub>SM</sub>         |   |      | 1     | 100   | A          |  |
| Body Diode Voltage                            | V <sub>SD</sub>         | I <sub>S</sub> = 3 A  |      | 1     | 1.2   | V          |  |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>         | -   |      |       | 40    | ns         |  |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>         | 1 <u>.</u>  |      |       | 20    | nC         |  |
| Reverse Recovery Fall Time                    | ta                      | $I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$              |      | 12.5  |       |            |  |
| Reverse Recovery Rise Time                    | t <sub>b</sub>          | 4   |      | 7.5   |       | ns         |  |

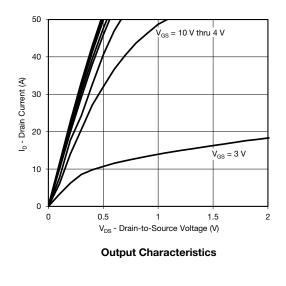
Notes:

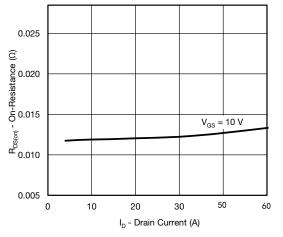
a. Pulse test; pulse width  $\leq$  300  $\mu s$ , duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

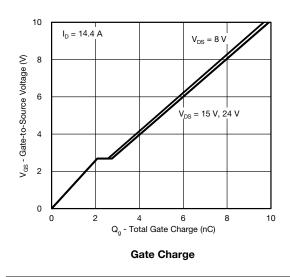


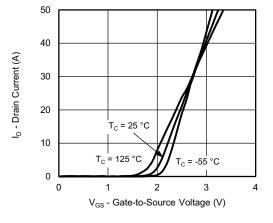
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



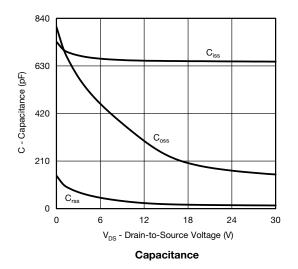


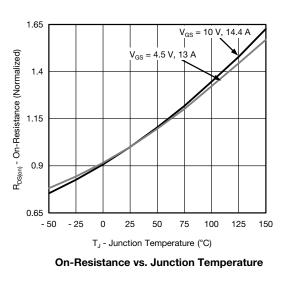
**On-Resistance vs. Drain Current** 





**Transfer Characteristics** 

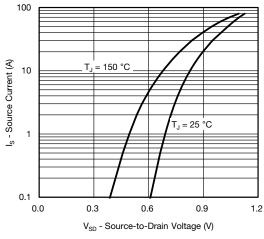




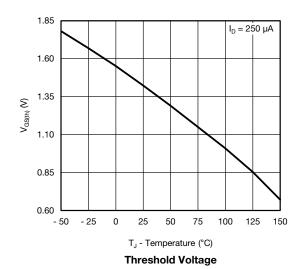
服务热线:400-655-8788



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



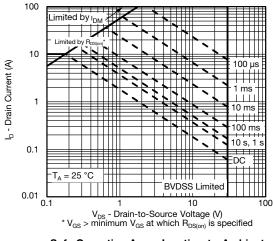
Source-Drain Diode Forward Voltage



0.025 I<sub>D</sub> = 15 A 0.020  $R_{DS(on)}$  - On-Resistance  $(\Omega)$ 0.015 0.010 0.005 T<sub>J</sub> = 25 °C 0.000 2 0 1 3 4 5 6 7 8 9 10 V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

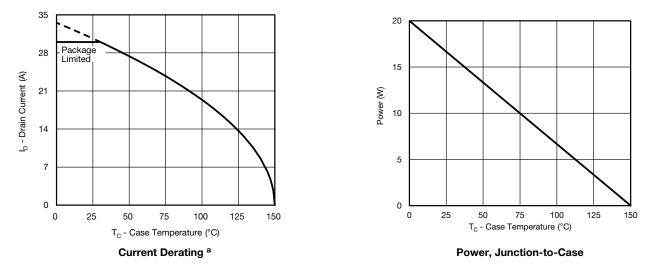




Safe Operating Area, Junction-to-Ambient



#### **TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

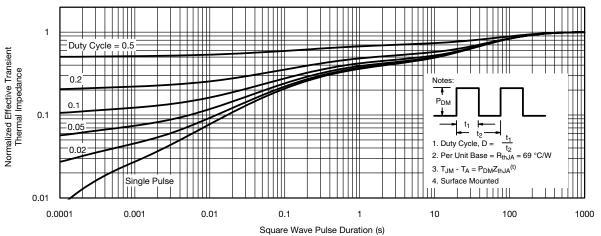


#### Note

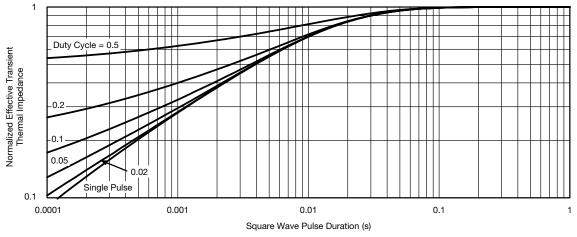
a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





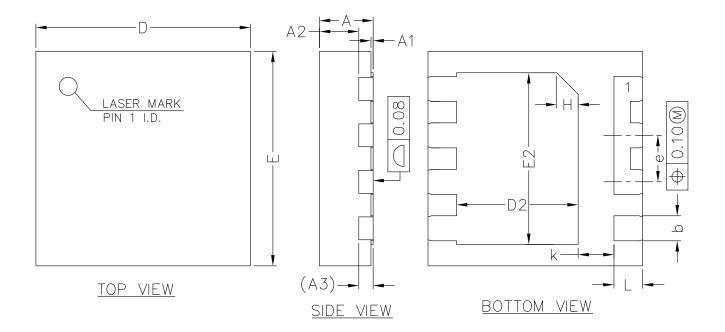


Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

WWW.VBsemi.com





<u>SIDE VIEW</u>

| SYMBOL | MIN     | NOM  | MAX  |  |  |
|--------|---------|------|------|--|--|
| А      | 0.70    | 0.75 | 0.80 |  |  |
| A1     | 0.00    | 0.02 | 0.05 |  |  |
| A2     | 0.50    | 0.55 | 0.60 |  |  |
| A3     | 0.20REF |      |      |  |  |
| b      | 0.30    | 0.35 | 0.40 |  |  |
| D      | 2.90    | 3.00 | 3.10 |  |  |
| E      | 2.90    | 3.00 | 3.10 |  |  |
| D2     | 1.60    | 1.70 | 1.80 |  |  |
| E2     | 2.30    | 2.40 | 2.50 |  |  |
| е      | 0.55    | 0.65 | 0.75 |  |  |
| К      | 0.40    | 0.50 | 0.60 |  |  |
| L      | 0.35    | 0.40 | 0.45 |  |  |

# COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)



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